Worst-case uncertainty construction for V&V

Bálint Patartics[†], Peter Seiler*, Bálint Vanek[†]

[†]Institute of Computer Science and Control (Hungary) *University of Michigan (USA)

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SZTAKI

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Patartics, Seiler, Vanek. Construction of an uncertainty to maximize the gain at multiple frequencies. ACC 2020.
Patartics, Seiler, Takarics, Vanek. Worst-case uncertainty construction via multifrequency gain maximization. Submitted to the TCST, 2020













Sahar, Edlerman, Agalarian, Balabanov, Gurfil. 2017.





Sahar, Edlerman, Agalarian, Balabanov, Gurfil. 2017.



Hard disk drive 40 experimental data from Seagate 20 [dB] -50 -40 -60 13 16 20 3 1 9 frequency [rad/s]





















































gain





















	H ₂ norm
nominal	
1000 samples avg.	
1000 samples max.	
worst-case	

	H ₂ norm
nominal	7.11
1000 samples avg.	
1000 samples max.	
worst-case	

	H ₂ norm
nominal	7.11
1000 samples avg.	7.12
1000 samples max.	
worst-case	

	H ₂ norm
nominal	7.11
1000 samples avg.	7.12
1000 samples max.	7.32
worst-case	

	H ₂ norm
nominal	7.11
1000 samples avg.	7.12
1000 samples max.	7.32
worst-case	7.42









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Practical considerations for industrial use

Given:

- 1. High fidelity, nonlinear simulation
 - a) Environmental/sensor noise
 - b) Uncertain parameters
- 2. Certification requirements

Analysis workflow:

- 1. Linearization including model uncertainties
 - a) Construction of this model from nonlinear simulation is not completely automated and often requires domain expertise.
- 2. Linear analyses
 - a) Further development of the algorithm for numerical reliability
 - b) Extension of the algorithm to more general uncertainties, e.g. delays, sector-bounded nonlinearities.
 - c) Compare different metrics (H_{∞} , multi-frequency, H_2) for their engineering relevance.
- 3. Monte Carlo simulations on high fidelity model
 - a) Study "bad" uncertainties from linear analysis to complement random samples. Generate several worst-cases based on different assumptions, e.g. frequency range of disturbances.